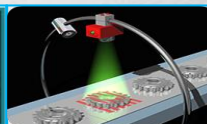
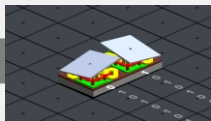
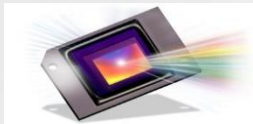


# Innovate in Industrial and Optical Sensing Applications using award-winning DLP® Technology



**Srikanth (Srik) Gurrapu**  
Marketing Manager,  
Texas Instruments, Inc



**Matt Soucek**  
Engineering Manager,  
Texas Instruments, Inc



# Agenda

- Introduction
- DLP Technology in Industrial Applications
- Optical sensing - 3D Machine Vision
  - DLP technology benefits
  - Development platforms
- Optical sensing - Spectroscopy
  - DLP technology benefits
  - Development platforms
- Q&A

# TI DLP® Products: a History of Innovation

1987

Dr. Larry Hornbeck invents digital micromirror device (DMD), known as the DLP® chip



1996

First commercial DLP system ships; enables first ultra portable projector



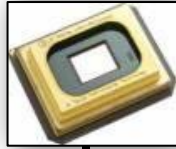
1998

DLP Products receives first **Emmy® Award** for Outstanding Achievement In Engineering In Development



2004

DLP Products becomes **highest volume MEMS supplier** worldwide



2009

Consumer devices begin to ship worldwide featuring **DLP Pico™ technology based projectors**



2011

Half of all movie theatres converted from film to digital enabled by DLP Cinema® technology



2012

New DLP development kit launches allowing developers to use DLP technology in new markets



2013

Increasing adoption of DLP Pico solutions



2015

First **automotive-qualified DLP chipset** for head-up display (HUD) applications

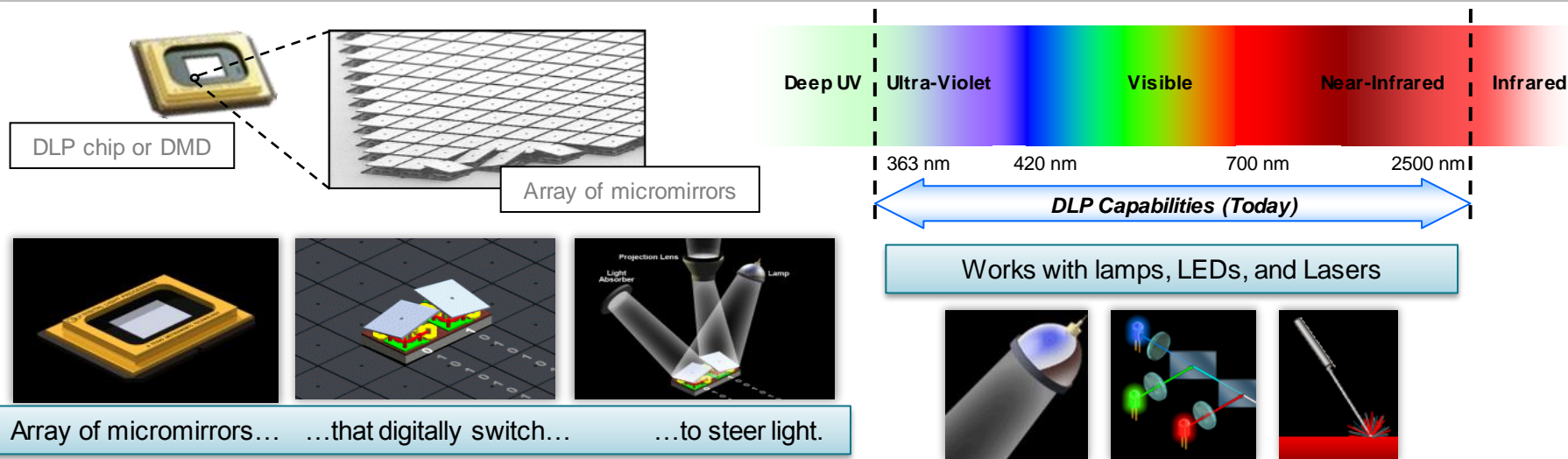


Dr. Hornbeck receives the **2014 Scientific and Technical Academy Award® of Merit (Oscar® statuette)** for the invention of the digital micromirror device (DMD) technology as used in DLP Cinema® projection.

For more than two decades, award-winning DLP Product innovations have solved some of the world's most complex display and light control applications.

Photo credit: Michael Yada / ©A.M.P.A.S. 3

# DLP MEMS technology enables many industrial non-display applications



**The DMD is a fast, efficient, and reliable spatial light modulator (SLM) offering:**

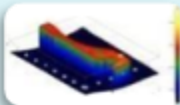
- 1) High Speed Switching – Switching of the mirrors at up to 32kHz
- 2) Extended Wavelength – Supporting UV and near-infrared (NIR) in addition to Visual spectrum
- 3) Wavelength Selection – Direct and modulate specific wavelengths of light through programmable pixel mapping

# “Hundreds” of Applications are possible

## Industrial

### Test & Measurement

- 3D Depth Measurement
- Spectrometers
- Food Inspection
- Fluid Analyzers



### Lighting

- Stage Lighting
- Adaptive Illumination



### Display & Digital Signage

- Advanced 3D Displays
- Planetariums

### Medical, Healthcare & Fitness

- 3D Dental Scanners
- Pharmaceutical Controls
- Vascular Imaging
- Ophthalmology
- Hyperspectral Imaging
- Phototherapy
- Microscopes



### Space, Avionics & Defense

- NIR Single Pixel Cameras
- 3D Biometrics
- Drug Identification



### Other Industrial

- PCB Lithography
- Flat Panel Lithography
- LCD Repair
- Computer-to-Plate Printing
- 3D Printers
- Laser Marking



### Factory Automation & Control

- 3D Machine Vision
- Inline Surface Inspection
- Pick & Place
- Inline Chemical Process Control



## Communication Equipment

### Telecom Infrastructure

- Reconfigurable Optical Add-Drop Multiplexers (ROADM)
- Wavelength Selective Switches (WSS)
- Variable Optical Attenuators (VOA)



## Personal Electronics

### Printers & Other Peripherals

- 3D Printers



# DLP Technology – Industrial Focus Areas

## 3D Machine Vision Sensing



Optical sensing

## 3D Printing



## Spectroscopic sensing



## Lithography



# Optical sensing – 3D Machine Vision

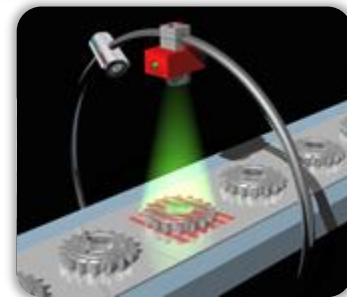


# Introduction to 3D Machine Vision

## What is 3D Machine Vision?

3D measurement is a fast and accurate way of gathering physical measurements of an object onto a computer in an organized manner, resulting in 3D scan data.

Once the scan data is on the computer, all of the dimensions of the object can be taken, such as length, width, height, volume, feature size, feature location, surface area, etc.



## Where is 3D Machine Vision Used?



Location & Guidance



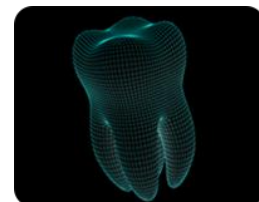
Measure & Inspect



Biometrics



Automated Optical Inspection

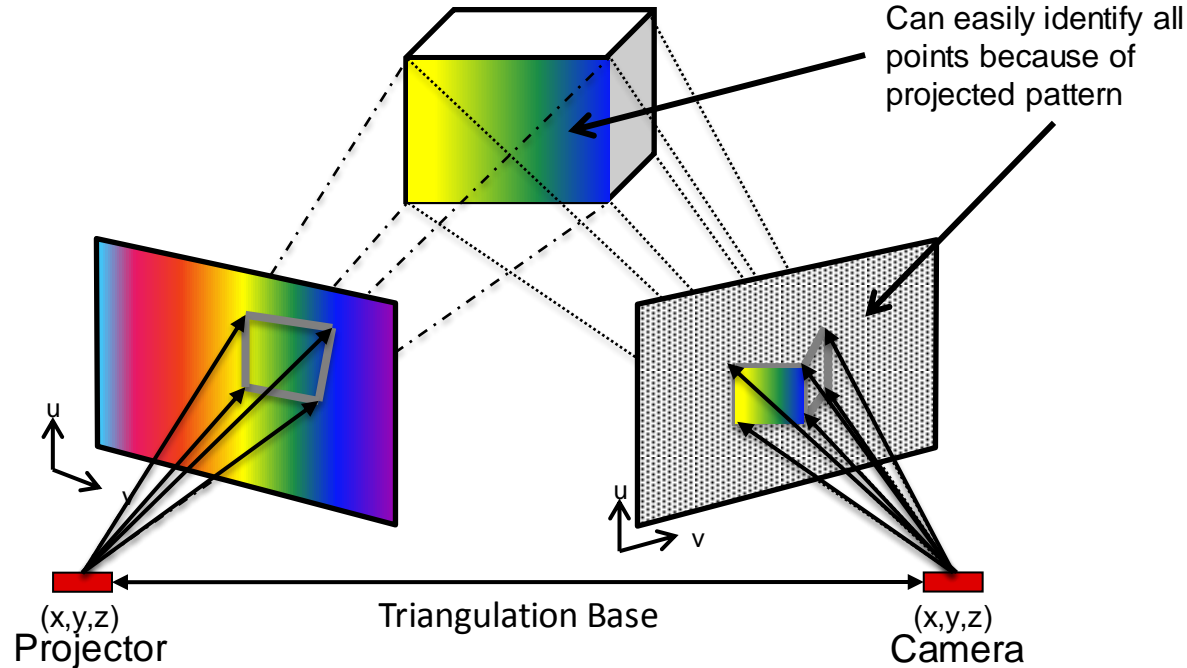


Medical Imaging



# 3D Machine Vision with Structured Light

- Patterns projected on an object inherently create identifiable features
- A camera triggered to each pattern captures these features



# DLP Programmable Patterns

*Programmable Patterns allow users to gain **full control** over the Structured Light System*

## Multiple patterns

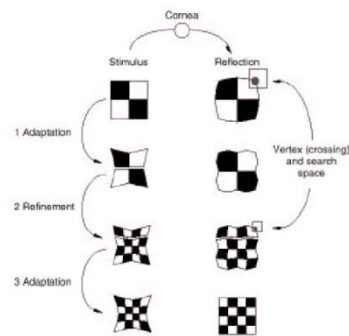
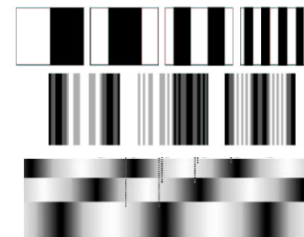
- Binary Code
- Gray Code or N-ary Codes
- Phase Shift

## Adaptive Patterns

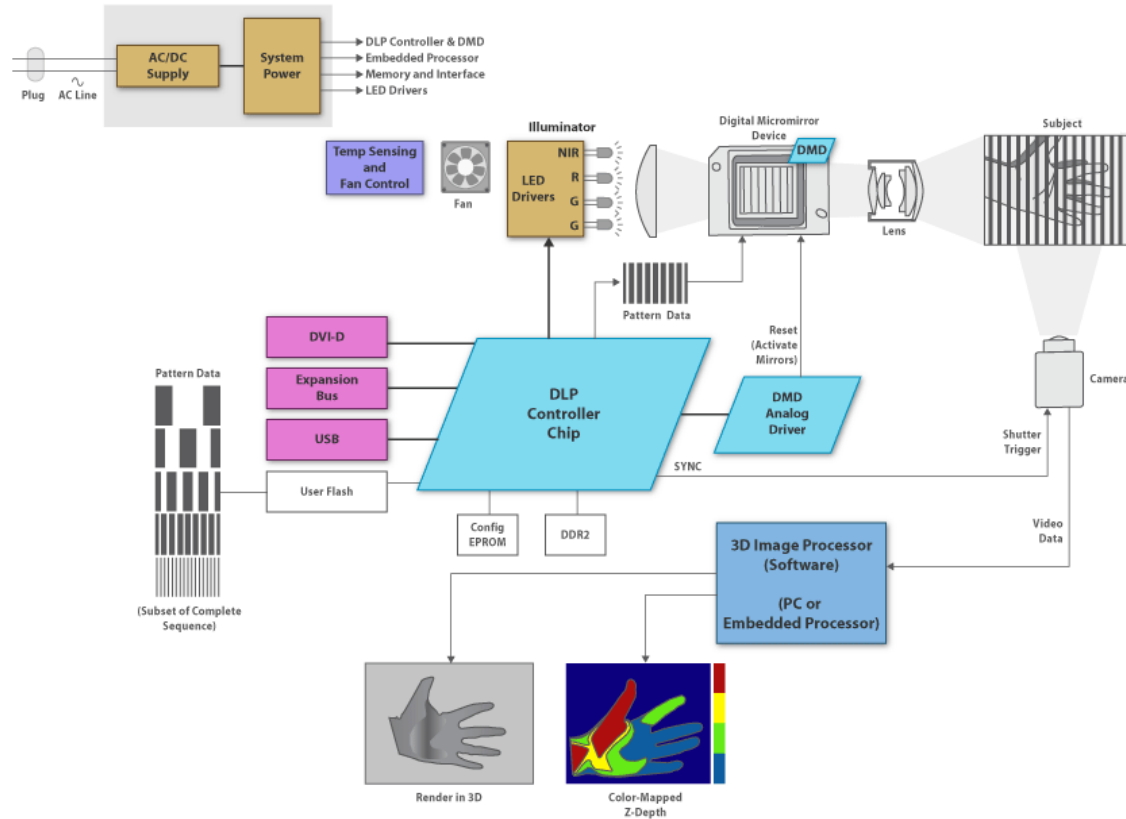
- Varying Color/Light and Pattern depending on object response and movement

## Hybrid Patterns

- Combination of several patterns

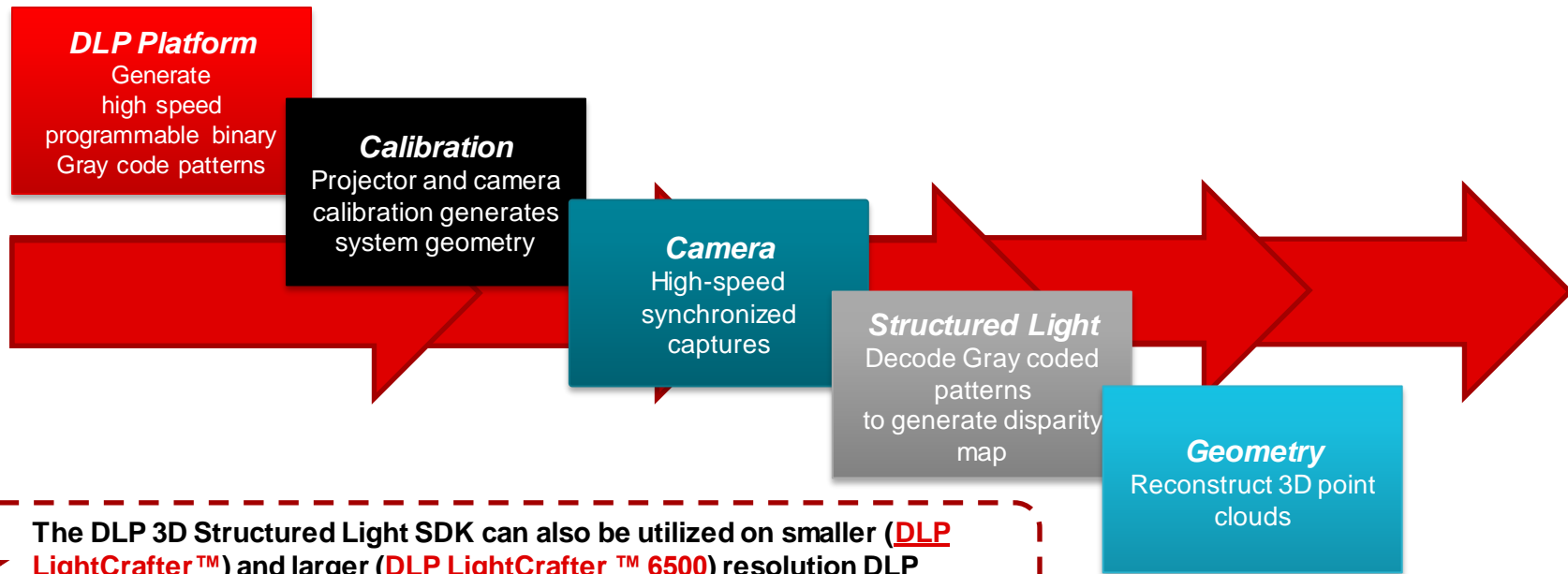


# 3D Machine Vision System Block Diagram



# DLP Structured Light SDK

A Complete 3D Machine Vision Development Software Solution

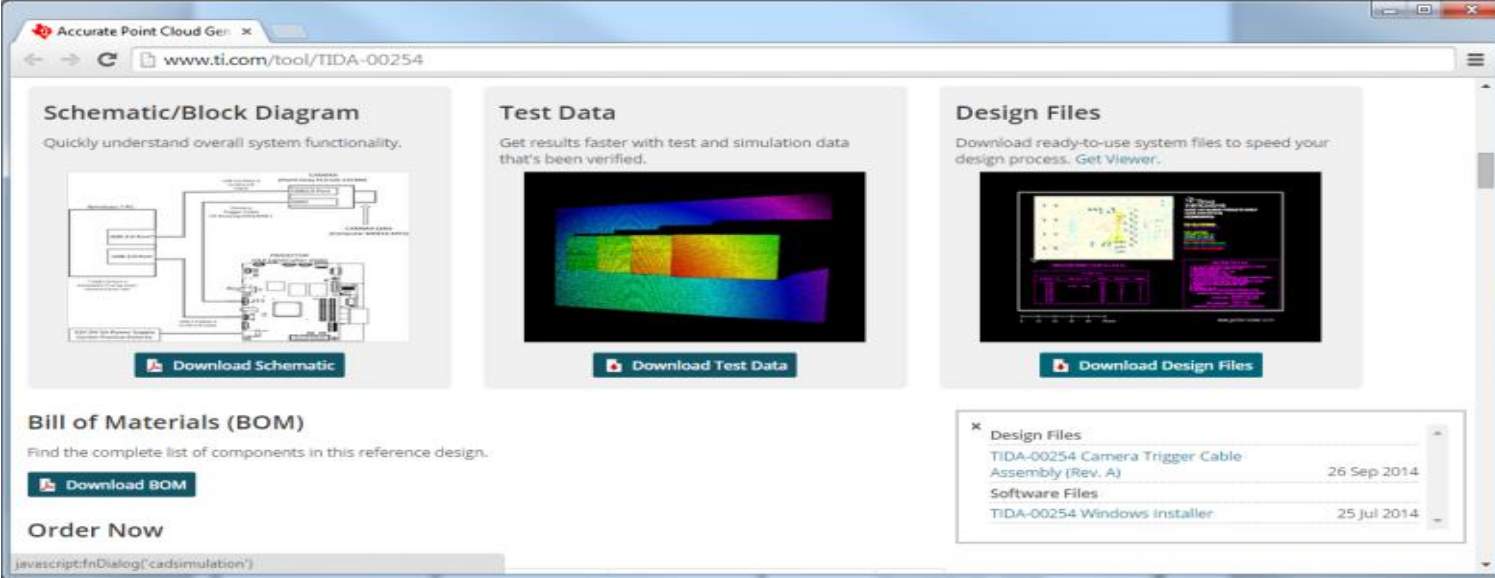


The DLP 3D Structured Light SDK can also be utilized on smaller ([DLP LightCrafter™](#)) and larger ([DLP LightCrafter™ 6500](#)) resolution DLP Evaluation Modules (EVMs) for portable and high resolution 3D scanning applications.



# Where to Find Software, the BOM, and the Trigger Cable Assembly Guide?

1. Go to the TIDA-00254 tool page (<http://www.ti.com/tool/TIDA-00254>)
2. Software installer listed under Download Design Files button (executable for SDK)
3. Schematic and BOM listed under their respective buttons



The screenshot shows a web browser window with the URL [www.ti.com/tool/TIDA-00254](http://www.ti.com/tool/TIDA-00254). The page is titled "Accurate Point Cloud Gen" and features several download options:

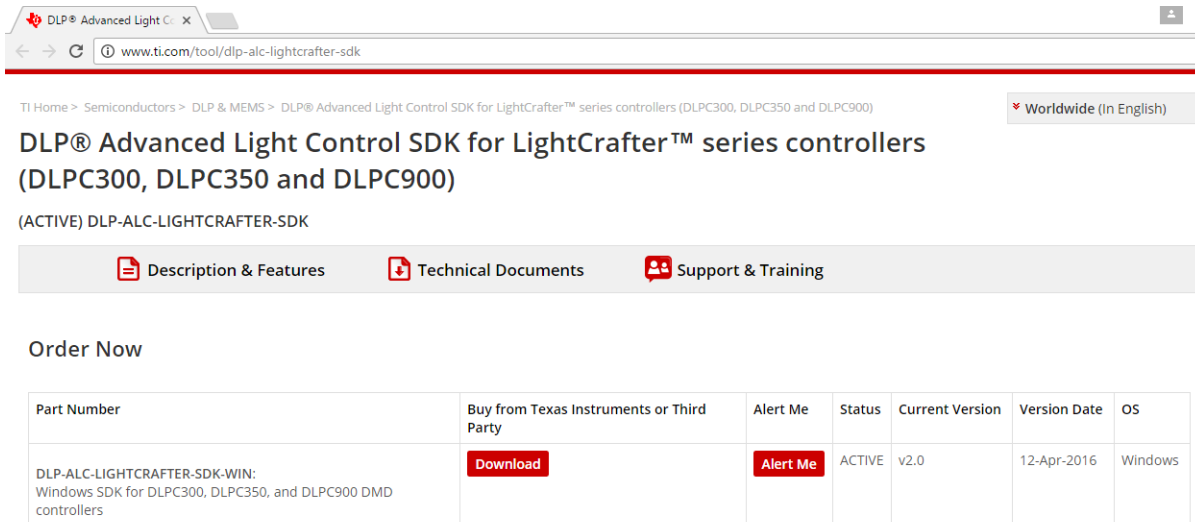
- Schematic/Block Diagram:** "Quickly understand overall system functionality." Includes a block diagram and a "Download Schematic" button.
- Test Data:** "Get results faster with test and simulation data that's been verified." Includes a 3D point cloud visualization and a "Download Test Data" button.
- Design Files:** "Download ready-to-use system files to speed your design process. Get Viewer." Includes a screenshot of a software interface and a "Download Design Files" button.
- Bill of Materials (BOM):** "Find the complete list of components in this reference design." Includes a "Download BOM" button.
- Order Now:** A section with a "javascript:fnDialog('cadsimulation');" link.

A dropdown menu for "Design Files" is open, showing the following items:

Item	Date
TIDA-00254 Camera Trigger Cable Assembly (Rev. A)	26 Sep 2014
Software Files	
TIDA-00254 Windows Installer	25 Jul 2014

# Where is the 3D Scanner Application and DLP Structured Light SDK source code?

1. One tool page on ti.com for three DLP LightCrafter EVM and controller platforms:  
(<http://www.ti.com/tool/dlp-alc-lightcrafter-sdk>)
2. User's guide for the Windows SDK: <http://www.ti.com/lit/ug/dlpu042/dlpu042.pdf>



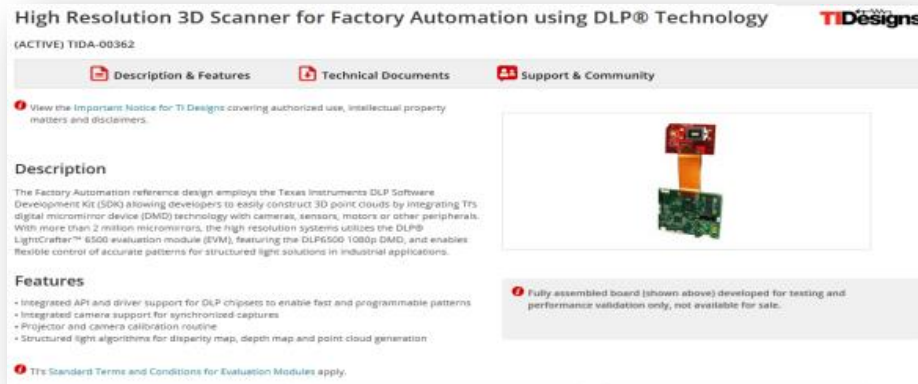
The screenshot shows a web browser window with the URL [www.ti.com/tool/dlp-alc-lightcrafter-sdk](http://www.ti.com/tool/dlp-alc-lightcrafter-sdk). The page title is "DLP® Advanced Light Control SDK for LightCrafter™ series controllers (DLPC300, DLPC350 and DLPC900)". Below the title, there are navigation tabs for "Description & Features", "Technical Documents", and "Support & Training". The "Order Now" section contains a table with the following data:

Part Number	Buy from Texas Instruments or Third Party	Alert Me	Status	Current Version	Version Date	OS
DLP-ALC-LIGHTCRAFTER-SDK-WIN: Windows SDK for DLPC300, DLPC350, and DLPC900 DMD controllers	<a href="#">Download</a>	<a href="#">Alert Me</a>	ACTIVE	v2.0	12-Apr-2016	Windows



# DLP6500 1080p 3D Scanner TI Design (TIDA-00362)

- Complete set of design files
- Mechanical schematic of metal frame
- Preliminary calibration for quick evaluation
- Executable calibration and scanning program
- TI test results using this exact design
- Access to SDK



High Resolution 3D Scanner for Factory Automation using DLP® Technology **TI Designs**

(ACTIVE) TIDA-00362

[Description & Features](#) [Technical Documents](#) [Support & Community](#)

View the Important Notice for TI Designs covering authorized use, intellectual property matters and disclaimers.

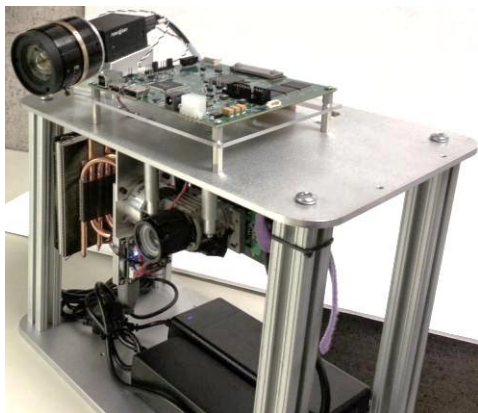
### Description

The Factory Automation reference design employs the Texas Instruments DLP Software Development Kit (SDK) allowing developers to easily construct 3D point clouds by integrating the digital micromirror device (DMD) technology with cameras, sensors, motors or other peripherals. With more than 2 million micromirrors, the high resolution system utilizes the DLP® LightCrafter™ 6500 evaluation module (EVM), featuring the DLP6500 1080p DMD, and enables flexible control of accurate patterns for structured light solutions in industrial applications.

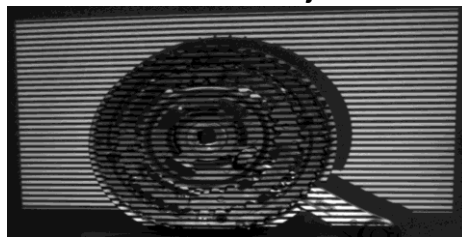
### Features

- Integrated API and driver support for DLP chipsets to enable fast and programmable patterns
- Integrated camera support for synchronized captures
- Projector and camera calibration routine
- Structured light algorithms for disparity map, depth map and point cloud generation

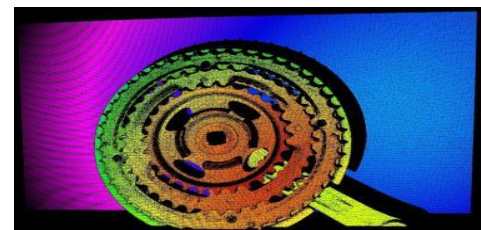
TI's Standard Terms and Conditions for Evaluation Modules apply.



Scanned Object



3D Point Cloud of Object



# Structured Light for PCB AOI Inline Inspection

## How it Works



Example system with four projectors to capture micron scale features on a PCB

## Why choose DLP technology?

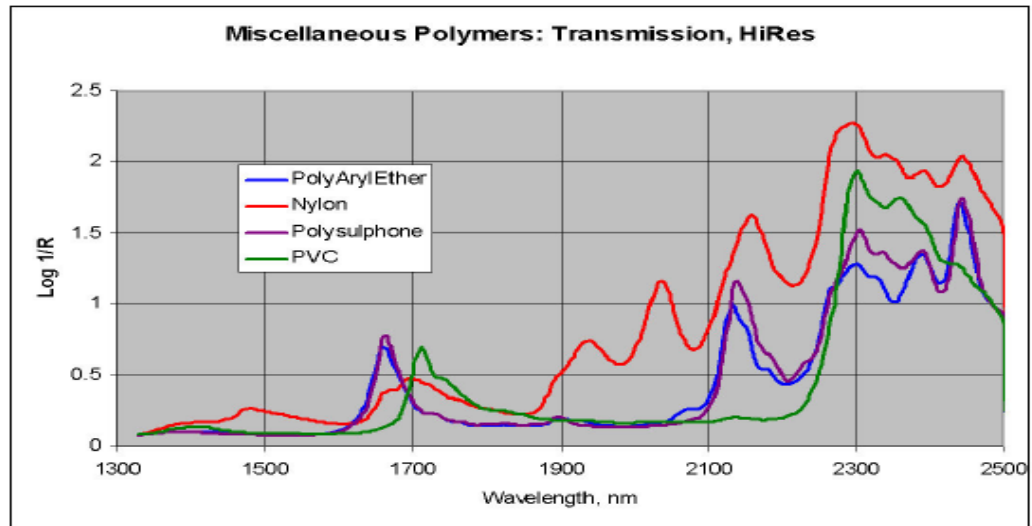
DLP Feature	System Benefits
High speed programmable patterns up to 1KHz with 8-bits grayscale pre-stored patterns	<ul style="list-style-type: none"><li>• Area based measurement</li><li>• Short scanning time</li><li>• Extreme flexibility in generating patterns</li></ul>
Customized DLP hardware and software reference design	<ul style="list-style-type: none"><li>• High system lumen efficiency without the need of polarizer</li><li>• Compact solution for size/cost reduction</li><li>• Reduced R&amp;D effort</li></ul>
Optical MEMS with product longevity	<ul style="list-style-type: none"><li>• Great pattern quality with high on/off contrast ratio</li><li>• Uniform mirrors providing excellent grayscale linearity and repeatability</li><li>• Proven technology with shipment in millions</li></ul>
Strong DLP ecosystem	<ul style="list-style-type: none"><li>• Quicker time-to-market with support from DLP Design Network partners</li><li>• Lower R&amp;D Investment</li></ul>

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# Optical sensing - Spectroscopy

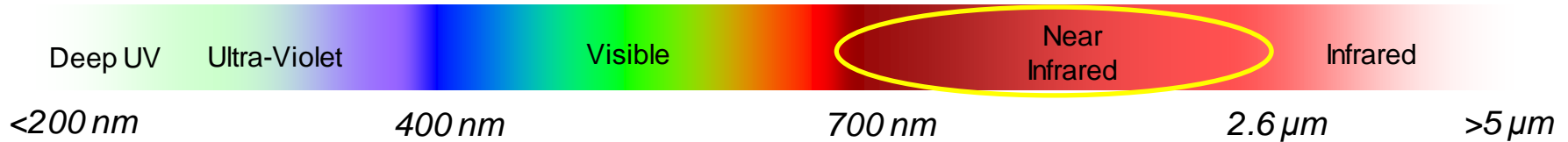
# Spectroscopy

- Spectroscopy is a powerful technique for recognizing and characterizing physical materials. It measures variations in absorption or emission for different wavelengths of light. Spectroscopy determines the degree of light interacting with the material and produces a signature known as a spectrum; the variation of light intensity as a function of wavelength.
- Example of a spectra for various plastics/polymers showing their spectral differences
- Spectrometers are used in:
  - Pharmaceuticals
  - Food
  - Agriculture
  - Petrochemical
  - Automotive Fluids
  - Manufacturing: QA/QC
  - Medical diagnostics
  - Security/counterfeit detection
  - Law Enforcement and forensics



# Electromagnetic/Light Spectrum

- Spectroscopy utilizes the light from the ultraviolet (UV) to the near-infrared (NIR):

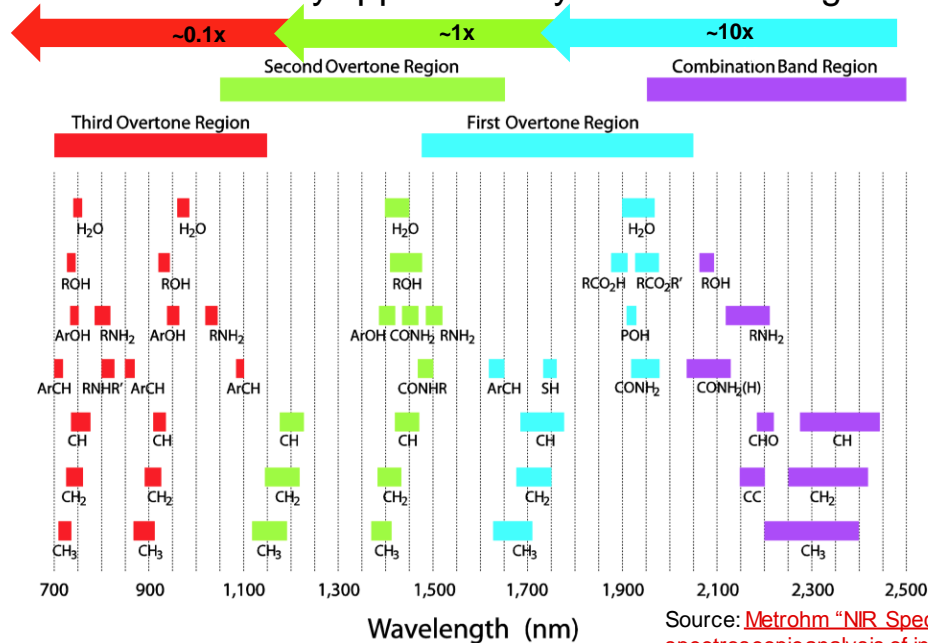


- Light energy in the near infrared region causes molecular chemical bonds to vibrate at specific frequencies. Overtones of those frequencies are observed from 650nm to 2600nm.
- There are three important and diagnostic functional groups of NIR overtones:
  1. **Hydroxy functional group: -OH**
    - Found in Water/Moisture, Carbohydrates, Sugars, Alcohols, Glycols, etc.
  2. **Amino functional group: -NH<sub>2</sub>**
    - Found in Proteins, Polymers (Nylons, Urethanes, etc.), Dyes, Pharmaceuticals, etc.
  3. **Alkyl/Aryl functional group: C-H aliphatic and aromatic hydrocarbons**
    - Found in Fats/Lipids, Fuels, Plastics and Polymers, etc.

# NIR Spectroscopy

- The following major overtones or harmonics observed in the NIR spectral region result from compounds featuring these functional groups

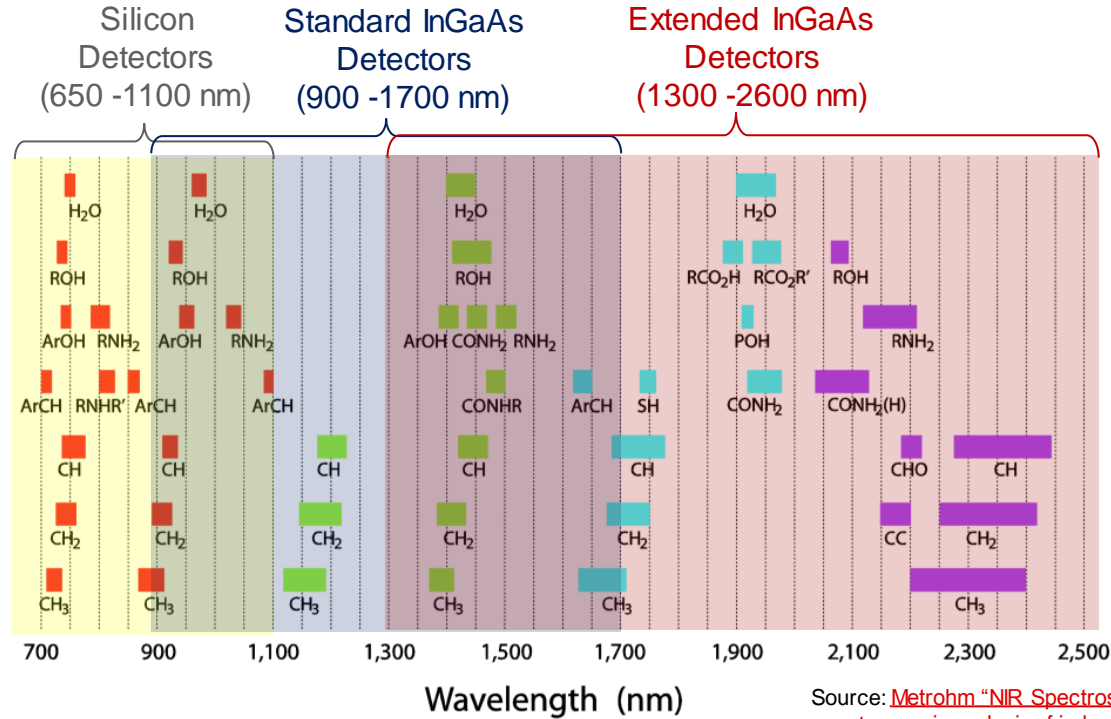
Relative absorbance decreases by approximately an order of magnitude with each overtone



Source: [Metrohm "NIR Spectroscopy: A guide to near-infrared spectroscopic analysis of industrial manufacturing processes"](#)

# NIR Photodetectors

- Detection of these major overtones depends on photodetector technology:

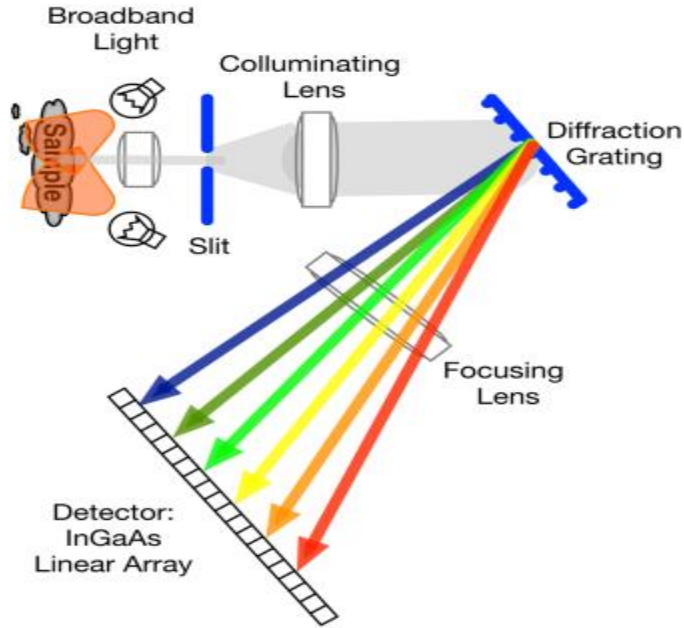


Source: [Metrohm "NIR Spectroscopy: A guide to near-infrared spectroscopic analysis of industrial manufacturing processes"](#)

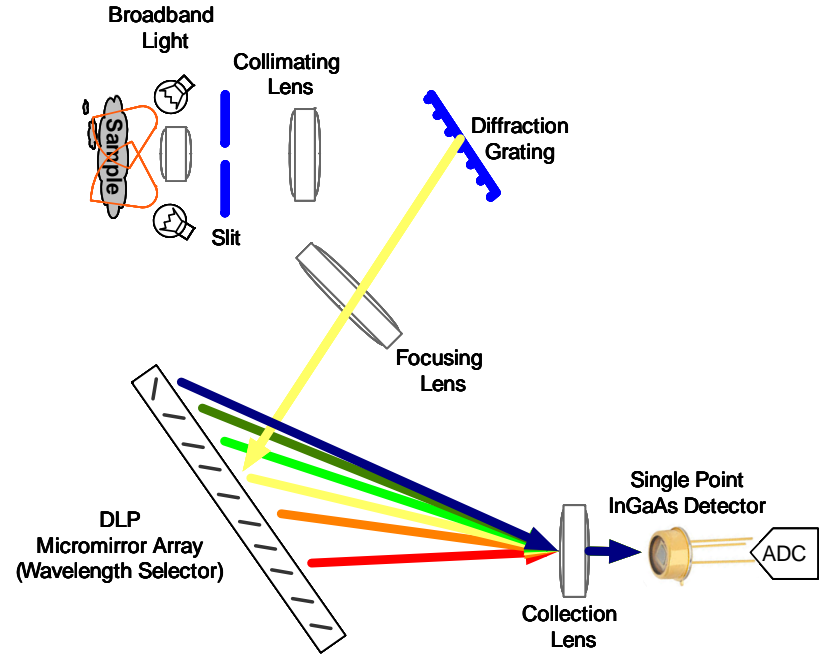


# DLP Technology-Based Spectroscopy

## Current technology: InGaAs linear array



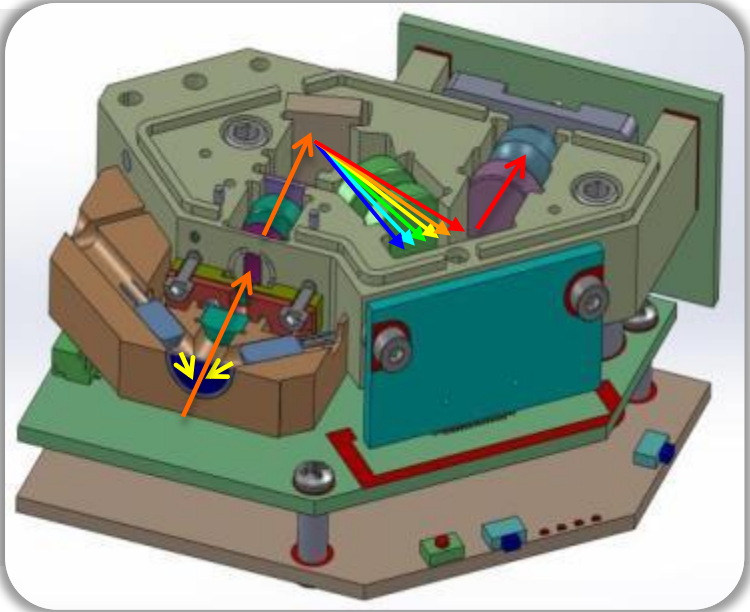
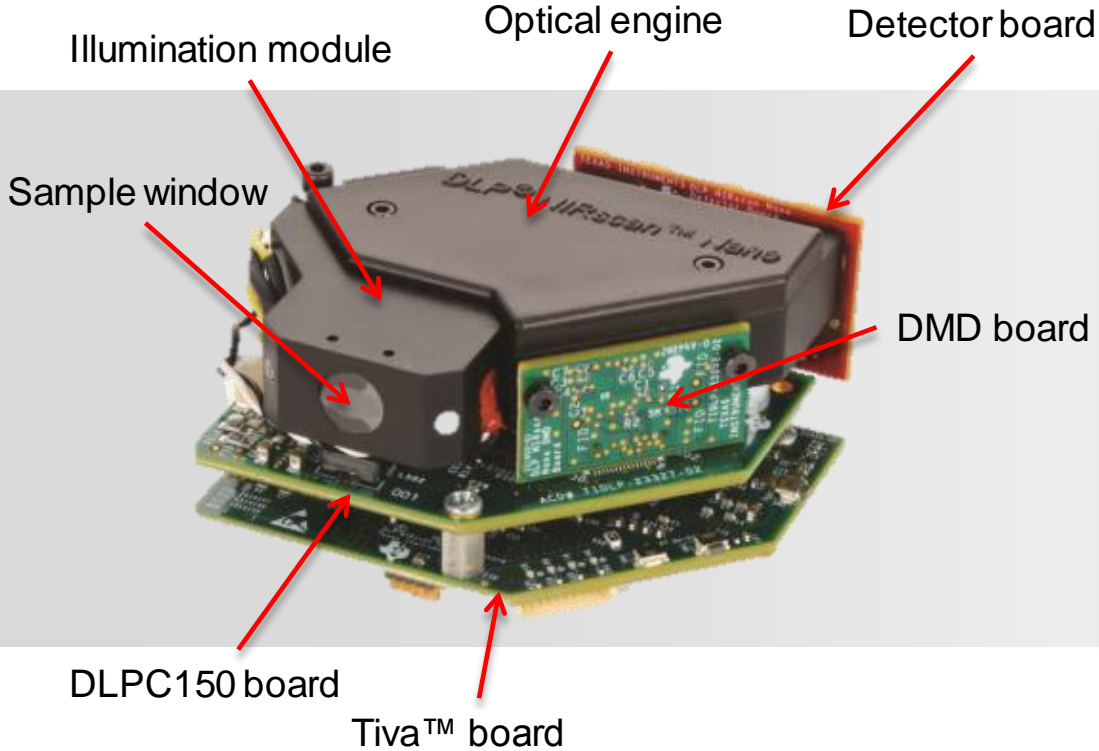
## DLP technology-based: DLP chip + single point InGaAs



# DLP Technology-Based Advantages

Linear Array Technology	DLP Technology-Based	Advantage
Linear InGaAs array detector have small pixels: 7.8 - 30 um wide x 125 - 500 um tall	Large InGaAs detector pixel: 1 - 2 mm diameter	Higher Performance
Linear InGaAs array detector with limited pixels: 128, 256, 512, or 1024	Pixels limited by DLP micromirror array size: <ul style="list-style-type: none"><li>• 854 x 480 on DLP2010NIR</li><li>• 912 x 1140 on DLP4500NIR</li></ul>	Higher Performance
Not programmable	Programmable: <ul style="list-style-type: none"><li>• Variable Intensity</li><li>• Variable Integration Time</li><li>• Resolution</li><li>• Complex Hadamard Patterns</li><li>• Custom Spectral Filters</li><li>• Compensate Optical Distortion and Physical Misalignment</li></ul>	Higher Performance
Linear InGas photodetecor cost: \$1500 - \$5000	DLP micromirror + single pixel InGaAs cost: \$200 - \$700	Lower Cost

# DLP Mobile Spectroscopy EVM



# Sampling Methods

- **Transmission/Transmittance**

- Used for liquids, films, transparent, and translucent materials
  - Oils, fuels, solvents, polymers/plastics, solutions, etc.
- Light directed through the sample and then captured by the system

- **Reflection/Reflectance**

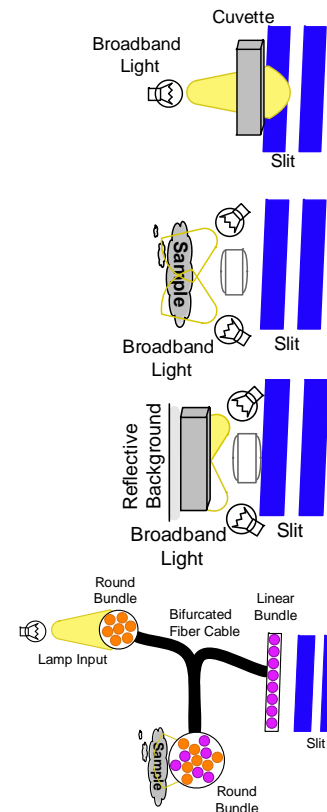
- Used for solids, powders, and polymers
- Light directed onto the surface of the solid and then the reflected light is captured by system

- **Transflectance**

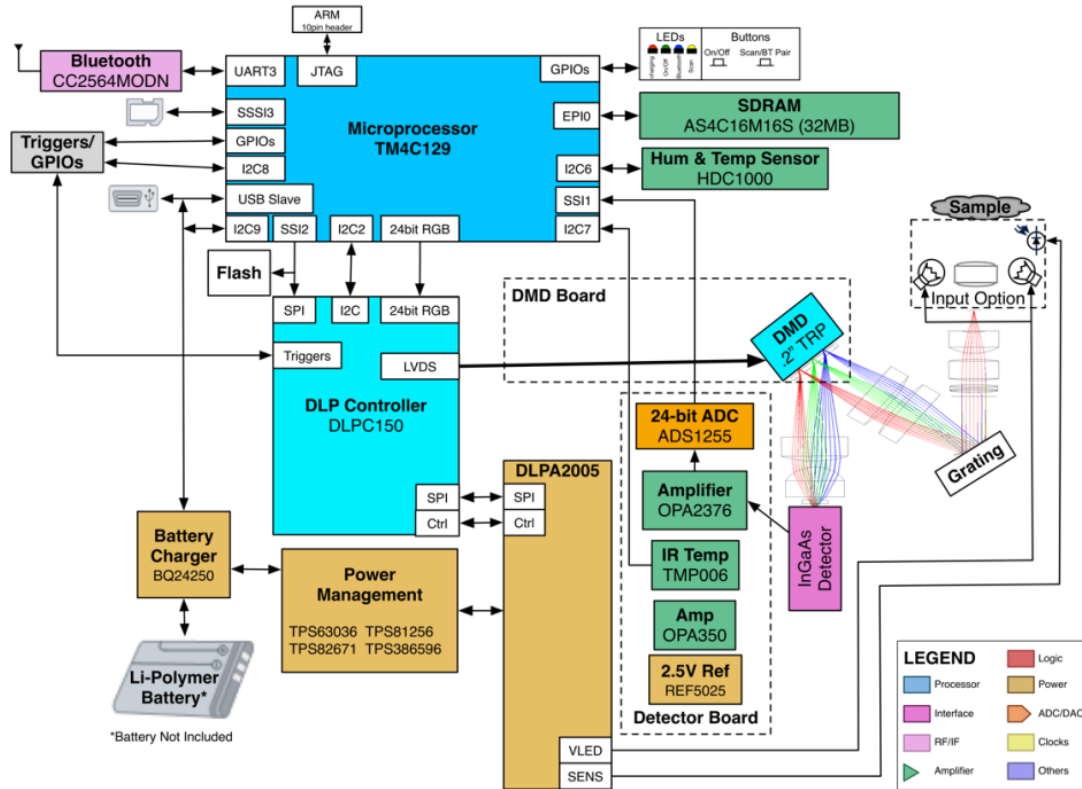
- Used for liquids, slurries, gels, pastes, polymers, and thin coatings on metals
- Used in dip-probe configuration with a fiber optic cable
- Light directed through the sample and reflected by the background material, passing through the sample twice

- **Fiber Optic Interfacing**

- Used for remote sampling
- Combines a light source and sample capture in one fiber bundle
- Transfers the light from the sample back into the system



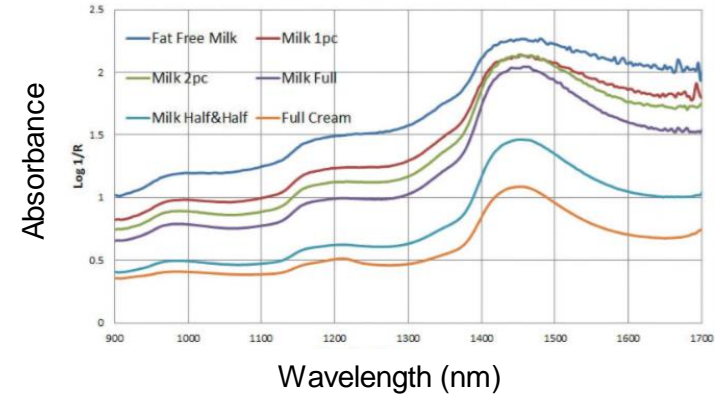
# DLP NIRscan™ Nano Block Diagram



The DLP NIRscan™ Nano EVM functions as a mobile NIR spectrometer!

# Spectroscopy Applications: Food

- NIR Spectroscopy can perform many measurement tasks in the food industry
- Examples of these tasks are:
  - **Quality assessment** of food by reporting:
    - Moisture
    - Carbohydrates, Sugar content (BRIX)
    - Proteins
    - Fat
    - Alcohol content for alcoholic beverages
  - **Confirmation** of the authenticity of oils and syrups
  - **Detection** of counterfeits or adulterations in food
    - Detection of unexpected flavor components in high value samples, such as olive oil, honey, and maple syrup
    - Measurement of saturation and trans-unsaturation in oil products
    - Detection of toxic or non-nutrient materials, such as melamine as a protein enhancer or “nitrogen booster” in food products (cereals, pet foods, dairy products, etc.)



# Example NIR Spectral Signatures in Food

Food	Sampling Method	Signature	Wavelength Range
Milk	Dip Probe	Fats, Melamine, Fillers	1400 - 1700 nm
Butter, Cheese, and Yogurt	Contact	Sugars, Proteins, Fats/Lactose	1100 - 1600 nm
White, Milk, and Dark Chocolate		Sugars, Fats	
Meat Products		Water, Proteins, Fat	1100 - 1700 nm
Fish		Proteins, Fats, Oils	
Soft Drinks	Dip Probe	Sugar, CO <sub>2</sub>	
Juices		Sugars	
Syrups		Sugars, Water	
Wine Fermentation Process		Sugars, Acid, Alcohols	
Beer Brewing Process		Sugars, Alcohols	
Oils		Poly/Transunsaturated Fats	
Produce Inspection	Contact and Non-Contact	Water, Sugars, Proteins, Fats/Lactose	



# Development Platforms and Reference Designs for Faster Development

# Development Resources and links

## Silicon – Extensive portfolio

13 DMD chips for non-display optical sensing applications

### [Featured Applications](#)

<http://www.ti.com/lstds/ti/dlp/advanced-light-control/applications-featured-applications.page>



## Development Platforms and Software

Several EVMs starting at \$599

<http://www.ti.com/lstds/ti/dlp/advanced-light-control/tools.page>



## TI Designs and reference designs

<http://www.ti.com/tool/TIDA-00362>

<http://www.ti.com/tool/TIDA-00554>

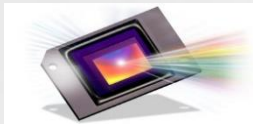


Extensive 3P network **worldwide** 20+ companies with 40+ solutions

<http://www.ti.com/lstds/ti/dlp/advanced-light-control/solutions-services.page>



# Innovate in Industrial and Optical Sensing Applications using award-winning DLP® Technology



**Srikanth (Srik) Gurrapu**  
Marketing Manager,  
Texas Instruments, Inc



**Matt Soucek**  
Engineering Manager,  
Texas Instruments, Inc

